Application/Control No.: Applicant(s)/Patent Under Reexamination 10/614,687 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ryan F. Pitaro 2174 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 02-2000 lizuka, Yoshio 709/223 US-6,029,198 A Α US-6,535,756 B1 03-2003 Simon et al. 600/424 В US-2003/0076336 04-2003 Fukao et al. 345/589 С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U Allegro, three-state, 2002, Page 1 ٧ W Х

'A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.